## Notice of References Cited Application/Control No. 10/561,314 Examiner ECE HUR Applicant(s)/Patent Under Reexamination YAHATA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,854,873 A	12-1998	Mori et al.	386/92
*	В	US-5,907,658 A	05-1999	Murase et al.	386/95
*	С	US-5,929,857 A	07-1999	Dinallo et al.	715/840
*	D	US-6,166,735 A	12-2000	Dom et al.	715/749
*	Е	US-6,381,398 B1	04-2002	Yamauchi et al.	386/52
*	F	US-6,580,756 B1	06-2003	Matsui et al.	375/240.08
*	G	US-6,701,064 B1	03-2004	De Haan et al.	386/95
*	Н	US-2006/0064716 A1	03-2006	Sull et al.	725/037
*	ı	US-2006/0188223 A1	08-2006	Ikeda et al.	386/095
*	J	US-2007/0005795 A1	01-2007	Gonzalez, Ruben	709/232
*	к	US-7,187,852 B1	03-2007	Bauer-Schwan et al.	386/98
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001332006 A	11-2001	Japan	SHIRAISHI et al.	G11B 19/02
	0					
	Р					
	α					
	R					*
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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